Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/053,585	NAYA ET AL.
Examiner	Art Unit
Christopher L. Chin	1641

SEARCHED					
Class	Subclass	Date	Examiner		
Updated	Search	10/15/2005	cc		
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INTERFERENCE SEARCHED				
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SEARCH NO (INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR
EAST search - see search report	10/15/2005 ,	cc